Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/218,913	HALL ET AL.	
Examiner	Art Unit	
Nashaat T. Nashed, Ph. D.	1656	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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